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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney Docket No. 20228-0013US1	Application No. 10/580,698	
Information Disclo	-	Applicant Damian Fiolka et al.		
(Use several sheets if necessary) (37 CFR §1.98(b))		Filing Date November 29, 2006	Group Art Unit 2872	

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Examiner Signature	/Jade Chwasz/	Date Considered 12/28/2010		
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